Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,367	KATO ET AL.	
Examiner -	Art Unit	
Ronald W. Leja	2836	

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Class	Subclass	Date	Examiner
361	173	4/6/06	AWL
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INTERFERENCE SEARCHED					
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See Atla	ched	4/6/06	ANU		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
5 ee Affached Text	4/6/16	PWL	
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